Active Sensing

What is Active Sensing?

For some, it's a hobby!

"Object" to be Inferred



"Measurement"



"Measurement"















Background and Motivation

Sensors, Sensors Everywhere



Images, sound, GPS, accelerometer, proximity,... (Apple)



 NH_3 , CI_2 ,... (NASA)





Integral to Science, Engineering, Discovery







Star-Birth Clouds • M16 PRC95-44b • ST Scl OPO • November 2, 1995 J. Hester and P. Scowen (AZ State Univ.), NASA

NASA/ESA



Inevitable Data Deluge!



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24 years/year !
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YouTube Upload Rate (March 2010): 24 hours/minute ?!?! (www.webpronews.com)



The Economist, February 2010

Challenges for Sensing/Processing Systems

Technology:

technologically impossible to sense/observe everything, everywhere, all the time ⇒incomplete, missing, or indirect data are the norm

Uncertainty:

experiments/measurements are noisy, corrupted or unreliable! ⇒info-processing and decision-making must be robust to uncertainty

Complexity:

systems can be ultra high-dimensional ⇒modeling/approximation is formidable, mathematically & computationally

Diversity:

data from disparate sources \Rightarrow integration of info from sensors, experiments, databases, human intel, etc.

Approaches:

⇒Rethink Traditional Sensing Strategies ⇒Integration of Sensing and Processing

Active Sensing

-- An Engineering Example --

Wide-field Infrared Survey Explorer (WISE)



- \rightarrow Need to shield IR (heat) from its own instruments
- → Sensitive instruments housed in solid hydrogen
- → Expected lifetime: 10 months!

WISE Mission:

(http://www.nasa.gov/mission_pages/WISE/mission/index.html)

"...the infrared surveyor will spend six months mapping the whole sky. It will then begin a second scan to uncover even more objects and to look for any changes in the sky that might have occurred since the first survey. This second partial sky survey will end about three months later when the spacecraft's frozen-hydrogen cryogen runs out..."



Fornax Galaxy Cluster, Feb. 17 2010

Astronomical Imaging "On a Budget"



Noisy, non-adaptive sampling

Recovery from non-adaptive samples (1/20 "discoveries" are errors)



original signal (~0.8% non-zero components)



Noisy adaptive sampling



Recovery from adaptive samples (1/20 "discoveries" are errors)

Active Sensing for Sparse Recovery -- Preliminaries and Formalization --





Many signals exhibit sparsity in the canonical or "pixel" basis

Communication signals often have sparse frequency content

Natural images often have sparse wavelet representations

Notion of sparsity extends to other models (task-specific dictionaries, manifolds, etc.)

Sparse Recovery Goal: Identify the locations of the nonzeros!

A Sparse Signal Model

Signals of interest are vectors $x \in \mathbb{R}^n$



Non-adaptive Sampling

Non-adaptive observations:

$$y_i = x_i + z_i$$
$$z_i \stackrel{\text{iid}}{\sim} \mathcal{N}(0, 1)$$



Alternative: Sequential Experimental Design

$$y_{i,j} = \begin{cases} x_i + \gamma_{i,j}^{-1/2} z_{i,j}, & \gamma_{i,j} > 0, \ i = 1, \dots, n, & j = 1, \dots, k \\ 0 & \gamma_{i,j} = 0, \ i = 1, \dots, n, & j = 1, \dots, k \end{cases}$$
$$z_{i,j} \stackrel{\text{iid}}{\sim} \mathcal{N}(0, 1)$$
$$j \text{ indexes the observation step}$$
$$k \text{ is the total number of steps}$$
$$\gamma_{i,j} \ge 0 \text{ is the precision of observation } y_{i,j}$$

 $\Rightarrow y_{i,j} \sim \mathcal{N}\left(x_i, 1/\gamma_{i,j}\right)$ when $\gamma_{i,j} \neq 0$



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 when $\gamma_{i,j} \neq 0$

Precision is increased (decreased) by:

- Averaging more (fewer) repeated samples
- Longer (shorter) observation times

Total precision subject to a global constraint:

$$\sum_{j=1}^{k} \sum_{i=1}^{n} \gamma_{i,j} \leq R(n)$$
Proportional to total # samples,
total time, total energy,
cryogen life, etc.

Support Recovery

Goal: Estimate the signal support set $S := \{i \in \{1, ..., n\} : x_i \neq 0\}$



Definition: A *threshold test* is an estimator of the form $\widehat{S}_{\tau}(y) := \{i \in \{1, ..., n\} : y_i > \tau\}$ A Simple Active Sensing Approach

Recovery From Non-Adaptive Measurements

Goal: Estimate S with *no* errors (ie, $\hat{S} = S$) from noisy measurements How large must amplitude μ be?



Exact support recovery $\Leftrightarrow \begin{cases} y_i > \tau \text{ for all } i \in S \\ y_i < \tau \text{ for all } i \in S^c \end{cases}$

Let $|\mathcal{S}| = s$, then n - s components of x are equal to zero.

Fundamentally a Multiple Hypothesis Test

Test signal present vs. signal absent at each coordinate:



Non-Adaptive Support Recovery

How large must μ be to ensure probability of error tends to zero?

$$\mathbb{P}(\widehat{S} \neq S) \le (n-s)\mathbb{P}(y_i > 0 | x_i = 0) + s \mathbb{P}(y_i < 0 | x_i = \mu)$$

 $\leq \frac{n-s}{2} \exp\left(-\frac{\tau^2}{2}\right) + \frac{s}{2} \exp\left(-\frac{(\mu-\tau)^2}{2}\right)$ Want each term to tend to zero $\mu\gtrsim au+\sqrt{2\log s}$ $au\gtrsim \sqrt{2\log(n-s)}$ $\mu \gtrsim \sqrt{2\log(n-s)} + \sqrt{2\log s}$

Necessary condition: $\mu \gtrsim \sqrt{\log n}$

Adaptive Approach: Sequential Thresholding

Sequential Thresholding

initialize:
$$S_0 = \{1, ..., n\}, \gamma_{i,j}^{-1} = 2$$

for $j = 1, ..., k$
1) measure: $y_{i,j} \sim \mathcal{N}(x_i, 2)$, $i \in S_{j-1}$
2) threshold: $S_j = \{i : y_{i,j} \ge 0\}$
end
output: $S_k = \{i : y_{i,k} \ge 0\}$

probability of error:
$$\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) = \mathbb{P}(\{\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset\} \cup \{\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset\})$$

 $\leq \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) + \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset)$



 $\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) \leq \mathbb{P}\left(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset\right) + \mathbb{P}\left(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset\right)$

$$\begin{split} \mathbb{P}\left(\mathcal{S}^{c} \cap \mathcal{S}_{k} \neq \emptyset\right) &= \mathbb{P}\left(\bigcup_{i \notin \mathcal{S}} \bigcap_{j=1}^{k} y_{i,j} > 0\right) \\ &\leq \sum_{i \notin \mathcal{S}} \mathbb{P}\left(\bigcap_{j=1}^{k} y_{i,j} > 0\right) \\ &= \sum_{i \notin \mathcal{S}} 2^{-k} = \frac{n-s}{2^{k}} \end{split}$$



 $\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) \leq \mathbb{P}\left(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset\right) + \mathbb{P}\left(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset\right)$

$$egin{aligned} \mathbb{P}\left(\mathcal{S}\cap\mathcal{S}_{k}^{c}
eq \emptyset
ight) &= \mathbb{P}\left(igcup_{j=1}^{k}igcup_{i\in\mathcal{S}}y_{i,j} < 0
ight) \ &\leq rac{ks}{2}\exp\left(-rac{\mu^{2}}{4}
ight) \end{aligned}$$

Probability of Error Bound

$$\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) \leq \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) + \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset)$$
$$\leq \frac{n-s}{2^k} + \frac{ks}{2} \exp\left(-\frac{\mu^2}{4}\right)$$
$$= \frac{n-s}{2^k} + \frac{1}{2} \exp\left(-\frac{(\mu^2 - 4\log(ks))}{4}\right)$$

Choose $k = \log_2 n^{1+\epsilon}$ and consider high-dimensional limit...

$$\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) \leq \frac{n-s}{2^k} + \frac{1}{2} \exp\left(-\frac{(\mu^2 - 4\log(s(1+\epsilon)\log_2 n))}{4}\right)$$

Probability of error goes to zero if

$$\mu\gtrsim\sqrt{4\log(s(1+\epsilon)\log_2 n)}$$

(Malloy & Nowak, 2011)

Improvements Through Sequential Design

$$ext{non-sequential:} \quad \mu \ \gtrsim \ \sqrt{2\log(n-s)} + \sqrt{2\log s} \quad \quad ext{(necessary)}$$

sequential thresholding: (sufficient)

$$\mu \gtrsim \sqrt{4 \log(s(1+\epsilon) \log_2 n)}$$
$$\cong 2 \sqrt{\log s + \log \log_2 n}$$

significant gains when $s \ll n$

greater sensitivity for same precision budget or lower experimental requirements for equivalent sensitivity

Active Sensing for Sparse Recovery -- A Relaxed Error Criteria --

Measuring Error: False Discoveries



Here, FDP = **3/5**

Measuring Error: Non-Discoveries



Also interested in quantifying false negatives (Type II errors)

Definition: The Non-Discovery Proportion (NDP) of \widehat{S} is NDP $(\widehat{S}) := \frac{|S \setminus \widehat{S}|}{|S|} = \frac{\# \text{ signal components missed}}{\text{total }\# \text{ signal components}}$

Here, NDP = **5/7**



To determine performance in high-dimensional settings (large n), we consider *asymptotic* behavior of FDP and NDP

Assume sublinear sparsity: $|S| = n^{1-\beta}$ for some fixed $0 < \beta < 1$

e.g.,
$$\beta = 3/4 \Rightarrow \begin{array}{c} n = 10000 \\ n = 1000000 \end{array} \xrightarrow{\rightarrow} |\mathcal{S}| = 10 \\ \rightarrow |\mathcal{S}| = 32 \end{array}$$

Theorem: (Donoho & Jin, 2003) Assume x has $n^{1-\beta}$, $\beta \in (0, 1)$, nonzero components of amplitude $\sqrt{2r \log n}$, r > 0. If $r > \beta$, there exists a threshold test that yields an estimator $\widehat{S} = \widehat{S}(y)$ for which

$$\mathsf{FDP}(\widehat{\mathcal{S}}) \xrightarrow{P} 0$$
, $\mathsf{NDP}(\widehat{\mathcal{S}}) \xrightarrow{P} 0$, as $n \to \infty$

where \xrightarrow{P} denotes convergence in probability. Further, if $r < \beta$, there does not exist a threshold test that can guarantee that both NDP and FDP tend to zero as $n \to \infty$.

Sharp Delineation in "Parameter Space"



What to Do in Low SNR Settings?

What if no signal component amplitudes exceed $\sqrt{2\beta \log n}$?



Cannot reliably estimate, but what determinations can be made?

Notice:

- As τ decreases, NDP gets closer to 0 (fewer signal components are missed)
- But still very unsure which entries are signal components

 \Rightarrow Take a closer look at most significant components

Idealized Example



Distilled Sensing (DS)

Input: Number of observation steps: kPrecision per step: R_j s.t. $\sum_{j=1}^k R_j \leq R(n)$ Initialize: Index set $I_1 = \{1, 2, ..., n\}$ Loop: For each step j = 1 to k1) Allocate precision uniformly over I_j : $\gamma_{i,j} = R_j/|I_j|$, $i \in I_j$ 2) Collect observations $y_{i,j}$ for $i \in I_j$ 3) Refinement/distillation: $I_{j+1} = \{i \in I_j : y_{i,j} > 0\}$ Output: Final observations: $y_{\text{DS}} := y_{i,k}$, $i \in I_k$ *To recover negative components, replace $y_{i,j}$ by $-y_{i,j}$ in distillation step

Key Idea: $|I_{j+1}| \approx |I_j|/2$ when x is sparse

- Assume $R_{j+1}/R_j = \rho > 1/2$, then $\gamma_{i,j+1} = \frac{R_{j+1}}{|I_{j+1}|} \approx 2\rho \frac{R_j}{|I_j|} = 2\rho \gamma_{i,j} \text{ (for } i \in I_j \cap I_{j+1})$

SNR improvement by $2\rho > 1$

Equal Allocation of Sensing Resources

Theorem: (JH, R. Castro, and R. Nowak, 2008) Assume x has $n^{1-\beta}$, $\beta \in (0,1)$, nonzero components, and let $R_j = n/k$ (equal precision allocation) for a fixed $k \in \mathbb{N}$. If the signal component amplitudes exceed $\sqrt{2\beta \frac{k}{2^{k-1}} \log n}$, then there exists a threshold test that yields an estimator $\widehat{S} = \widehat{S}(y_{\text{DS}})$ for which

 $\mathsf{FDP}(\widehat{\mathcal{S}}) \xrightarrow{P} 0$, $\mathsf{NDP}(\widehat{\mathcal{S}}) \xrightarrow{P} 0$, as $n \to \infty$.



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Recall: Noisy Astronomical Imaging



Non-adaptive observations

Non-adaptive recovery (FDP = 0.05)



original signal (~0.8% non-zero components)



Adaptive recovery (FDP = 0.05)

Unequal Allocation of Sensing Resources...



Theorem: (JH, R. Castro, and R. Nowak, 2009) Assume x has $n^{1-\beta}$, $\beta \in (0,1)$, nonzero components having amplitude at least $\mu(n)$. Choose $k = \lceil \log_2 \log n \rceil + 2$, and precision budget allocated over observation steps such that $\sum_{j=1}^{k} R_j \leq n$, $R_{j+1}/R_j = \rho > 1/2$ for $j = 1, \ldots, k-2$, $R_1 = c_1 n$, and $R_k = c_k n$ for $c_1, c_k \in (0, 1)$. From the output of the DS procedure, construct the estimate

$$\widehat{\mathcal{S}}_{\mathsf{DS}} := \left\{ i \in I_k : y_{i,k} > \sqrt{2/c_k} \right\}$$

If $\mu(n)$ is any arbitrarily slowly growing function of n, then

$$\mathsf{FDP}(\widehat{\mathcal{S}}_{\mathsf{DS}}) \xrightarrow{P} 0, \ \mathsf{NDP}(\widehat{\mathcal{S}}_{\mathsf{DS}}) \xrightarrow{P} 0, \ \mathsf{as} \ n \to \infty.$$

Adaptivity can provide $\sim \log n$ improvement in SNR and mitigate (or nearly <u>eliminate</u>) the curse of dimensionality!

Simulation



The Curse of Dimensionality... Non-adaptive vs. DS SNR= 8 |S| = 128n=2¹³ n=2¹⁰ 0.8 0.8 0.6 0.6 NDP NDP 0.4 0 0.2 0.2 0└ 0 $\mathbf{0}^{\mathrm{L}}_{\mathbf{0}}$ 0.2 0.4 0.6 0.8 0.2 0.8 0.6 0.4 FDP n=2¹⁶ FDP n=2¹⁹ 0.8 0.8 0.6 0.6 dq 0.4 NDP 0.4 0.2 0.2 0¹ 0 $\mathbf{0}^{\mathrm{L}}_{\mathbf{0}}$ 0.2 0.4 0.6 0.8 0.2 0.6 0.8 0.4

FDP

FDP

...and the Virtue of Adaptivity! Non-adaptive vs. DS SNR=8 $|\mathcal{S}| = 128$ n=2¹³ n=2¹⁰ 0.8 0.8 0.6 0.6 NDP NDP 0.4 0. 0.2 0.2 $\mathbf{0}^{\mathrm{L}}_{\mathbf{0}}$ 01 0 0.2 0.6 0.8 0.2 0.8 0.4 0.4 0.6 FDP FDP n=2¹⁶ n=2¹⁹ 0.8 0.8 0.6 0.6 NDP NDP 0.4 0.4 0.2 0.2 0 0 $\mathbf{0}^{\mathrm{L}}_{\mathbf{0}}$ 0.2 0.8 0.4 0.6 0.2 0.4 0.6 0.8 FDP FDP

Active Sensing for Sparse Recovery
-- Adaptive Compressive Sampling --

Improvements w.r.t. Other Resources?

Note that DS requires about 2n total measurements: n for first step about n/2 for second step about n/4 for third step...

Can we achieve noise-resilience benefits of DS using a reduced # of samples?

Noisy Compressive Sensing (CS) Observation Model

$$\begin{bmatrix} y_1 \\ \vdots \\ y_m \end{bmatrix} = \begin{bmatrix} \|A\|_F^2 \end{bmatrix} = n \times \begin{bmatrix} x_1 \\ x_2 \\ x_3 \\ \vdots \\ \vdots \\ x_n \end{bmatrix} + \begin{bmatrix} z_1 \\ \vdots \\ z_m \end{bmatrix} \\ z \sim \mathcal{N}(0, I_{m \times m})$$

Compressive DS

Theorem: (JH, R. Baraniuk, R. Castro, and R. Nowak, 2009) Assume x has $|S| = n^{1-\beta}$ nonzero components of amplitude μ . Collect $O(|S| \log n)$ adaptive random compressive measurements. When $\mu \succeq \sqrt{\log \log \log n}$, there exists a (tractable) recovery procedure for which

$$\mathsf{FDP}(\widehat{\mathcal{S}}_{\mathsf{CDS}}) \xrightarrow{P} 0, \ \mathsf{NDP}(\widehat{\mathcal{S}}_{\mathsf{CDS}}) \xrightarrow{P} 0, \ \mathsf{as} \ n \to \infty.$$

Support of random measurement matrix



- \leftarrow random combinations of all entries
- \leftarrow random combinations of top 1/2
- \leftarrow random combinations of top 1/4
- \leftarrow random combinations of top 1/8

 \leftarrow random combinations of top 1/16



Non-adaptive CS Recovery $(\sim 25\% \text{ measurements})$



Original Signal



Adaptive CS Recovery $(\sim 25\% \text{ measurements})$

Curse of Dimensionality: Compressed Sensing

Non-adaptive CS vs. CDS SNR= 12 |S| = 128





Generalization Beyond Gaussian Models

-- Sequential Thresholding --

General Set-up



$$y_i \sim \begin{cases} f_{\theta_0}, & i \notin \mathcal{S} \\ \\ f_{\theta_1}, & i \in \mathcal{S} \end{cases} \qquad i = 1, 2, \dots, n$$

Main Assumption: monotone likelihood ratio

Multiple Observations, Multiple Tests



$$\{y_{i,j}\}_{j\geq 1} \stackrel{\text{iid}}{\sim} f_{\theta_0}$$
 vs. $\{y_{i,j}\}_{j\geq 1} \stackrel{\text{iid}}{\sim} f_{\theta_1}$, $i = 1, 2, \dots, n$

Sequential Thresholding

sampling/precision budget: N = mn, $m \ge 1$

m samples per coordinate on average

log-likelihood ratio statistic:

$$t_i(m) = \sum_{j=1}^m \log \frac{f_{\theta_1}(y_{i,j})}{f_{\theta_0}(y_{i,j})}, \quad i = 1, 2, \dots, n$$

Collect samples in sets of size m/2 and consider sequences of log-LR stats

$$\underbrace{\underbrace{y_{i,1},\ldots,y_{i,m/2}}_{t_{i,1}(m/2)},\underbrace{y_{i,m/2+1},\ldots,y_{i,m}}_{t_{i,2}(m/2)},\ldots}_{t_{i,2}(m/2)}$$

sequential thresholding: define $\mu_0 := \text{median} (t_{i,j}(m/2) | \theta_0)$

$$t_{i,1}(m/2) \stackrel{\theta_0}{<} \mu_0$$
 else $t_{i,2}(m/2) \stackrel{\theta_0}{<} \mu_0$ else \cdots

a "cascade" of relatively poor detectors

Sequential Thresholding



if $\{y_{i,j}\} \sim f_{\theta_0}$, then false-positive probability is 1/2 at each step

Sequential Thresholding

Sequential Thresholding

input: $k \approx \log_2 n$ steps, $\mu_0 := \text{median}(t_{i,j}(m/2) | \theta_0)$ initialize: $S_0 = \{1, ..., n\}$ for j = 1, ..., k do for $i \in S_{j-1}$ do measure: $t_{i,j}$, $i \in S_{j-1}$ threshold: $S_j := \{i \in S_{j-1} : t_{i,j} > \mu_0\}$ end for end for output: S_k

total number of samples:

$$\mathbb{E}[N] = \sum_{j=1}^{k} m \mathbb{E}|\mathcal{S}_{j-1}| = m \sum_{j=1}^{k} \left(\frac{n-s}{2^{j-1}} + s\right)$$

$$\leq m(n-s+sk) \approx mn \quad (\text{when } s \ll n)$$

Spectrum Sensing



goal: find open channel(s) as quickly as possible

channel samples: $y_{i,j} \stackrel{\text{\tiny iid}}{\sim} \mathcal{CN}(0,\theta)$, $\theta_0 > \theta_1 = 1$

test statistic:
$$t_i(m) = \sum_{j=1}^m |y_{i,j}|^2 \sim \begin{cases} \Gamma(m, \theta_0), & i \notin S \\ \Gamma(m, 1), & i \in S \end{cases}$$



Spectrum Sensing Application

test statistic:
$$t_i(m) = \sum_{j=1}^m |y_{i,j}|^2 \sim \begin{cases} \Gamma(m, \theta_0), & i \notin S \\ \Gamma(m, 1), & i \in S \end{cases}$$



non-sequential: $\theta_0 \geq 2(m-1)(n-s)^{1/2m} \sim n^{1/2m}$ (necessary)

SPRT: $\theta_0 \gtrsim \frac{1}{m} \log s$

minimum requirement for any testing scheme with expected sample budget nm

sequential thresholding: $\theta_0 \geq \frac{1}{2m} \log(s \log_2 n)$ (sufficient)



sequential thresholding is about 10 times more sensitive (for equal scan time) or scans 3-4 times faster (for same reliability)

End of Presentation...